

74AVC4T245Q 4-Bit Dual-Supply Translating Transceiver with Configurable Voltage Translation and 3-State Outputs

GENERAL DESCRIPTION

The 74AVC4T245Q is a 4-bit, dual-supply voltage level transceiver with 3-state outputs and bidirectional level translation. The device can be used as two 2-bit transceivers or one 4-bit transceiver. The nAn and nBn are four data input-output ports. nDIR are the direction control inputs and n \overline{OE} are the output enable inputs. V_{CCA} and V_{CCB} are the supply pins. The supply voltage of V_{CCA} and V_{CCB} can range from 0.8V to 3.6V, making the device suitable for bidirectional translating among any of the 0.8V, 1.2V, 1.5V, 1.8V, 2.5V and 3.3V voltage nodes. The nAn, nDIR and n \overline{OE} signals are referenced to V_{CCA} and nBn signals are referenced to V_{CCB}.

When nDIR is set high, it allows transmission from nAn to nBn. When nDIR is set low, it allows transmission from nBn to nAn. $n\overline{OE}$ can be used to make the outputs disabled so that the buses are effectively isolated. In suspend mode, both nAn and nBn are in high-impedance state when either V_{CCA} or V_{CCB} input is at GND level.

This device is highly suitable for partial power-down applications using power-off leakage current (I_{OFF}) circuit. When the device is powered down, the current backflow will be prevented from passing through the device.

This device is AEC-Q100 qualified (Automotive Electronics Council Standard Q100 Grade 1) and the use of this device is suitable for automotive applications.

FEATURES

- AEC-Q100 Qualified for Automotive Applications Device Temperature Grade 1 T_A = -40°C to +125°C
 - $T_{A} = -40 \text{ C} \ 10 + 123 \text{ C}$
- V_{CCA} Supply Voltage Range: 0.8V to 3.6V
- V_{CCB} Supply Voltage Range: 0.8V to 3.6V
- Inputs Accept Voltages up to 3.6V
- +12mA/-12mA Output Current
- Data Rates:
 - 380Mbps (≥ 1.8V to 3.3V Translation)
 - 200Mbps (≥ 1.1V to 3.3V Translation)
 - 200Mbps (≥ 1.1V to 2.5V Translation)
 - 200Mbps (≥ 1.1V to 1.8V Translation)
 - 150Mbps (≥ 1.1V to 1.5V Translation)
 - 100Mbps (≥ 1.1V to 1.2V Translation)
- Outputs in High-Impedance State when V_{CCA} or V_{CCB} = 0V
- -40°C to +125°C Operating Temperature Range
- Available in a Green TSSOP-16 Package

APPLICATIONS

Personal Electronic Industrial Equipment Enterprise Infrastructures Telecom Equipment

PACKAGE/ORDERING INFORMATION

MODEL	PACKAGE DESCRIPTION	SPECIFIED TEMPERATURE RANGE	ORDERING NUMBER	PACKAGE TOP MARKING	PACKING OPTION	
74AVC4T245Q	TSSOP-16	-40°C to +125°C	74AVC4T245QTS16G/TR	MEATS16 XXXXX	Tape and Reel, 4000	

MARKING INFORMATION

NOTE: XXXXX = Date Code, Trace Code and Vendor Code.

<u>XXXXX</u>	
	Vendor Code
	Trace Code
	Date Code - Year

Green (RoHS & HSF): SG Micro Corp defines "Green" to mean Pb-Free (RoHS compatible) and free of halogen substances. If you have additional comments or questions, please contact your SGMICRO representative directly.

ABSOLUTE MAXIMUM RATINGS (1)

Supply Voltage Range, V_{CCA}
Suspend or 3-State Mode
Active Mode
A Ports0.5V to MIN (4.6V, V _{CCA} + 0.5V)
B Ports0.5V to MIN (4.6V, V _{CCB} + 0.5V)
Output Current, $I_O(V_O = 0V \text{ to } V_{CC})$
High-State or Low-State±50mA
Supply Current, I _{CC} , per V _{CCA} or V _{CCB} Pin 100mA
Ground Current, I _{GND} , per GND Pin100mA
Input Clamp Current, I _{IK} (V _I < 0)50mA
Output Clamp Current, I_{OK} (V _O < 0)50mA
Junction Temperature ⁽³⁾ +150°C
Storage Temperature Range65°C to +150°C
Lead Temperature (Soldering, 10s)+260°C
ESD Susceptibility
HBM
CDM

RECOMMENDED OPERATING CONDITIONS

Supply Voltage Range, V _{CCA} 0.8V to 3.6V
Supply Voltage Range, V _{CCB} 0.8V to 3.6V
Input Voltage Range, V ₁ 0V to 3.6V
Output Voltage Range, Vo
Suspend or 3-State Mode0V to 3.6V
Active Mode
A Ports0V to V _{CCA}
B Ports0V to V _{CCB}
High-State or Low-State Output Current, Io
Input Transition Rise or Fall Rate, $\Delta t / \Delta V$
V _{CCI} = 0.8V to 3.6V5ns/V (MAX)
Operating Temperature Range40°C to +125°C

OVERSTRESS CAUTION

1. Stresses beyond those listed in Absolute Maximum Ratings may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect reliability. Functional operation of the device at any conditions beyond those indicated in the Recommended Operating Conditions section is not implied.

2. The input and output voltage ratings may be exceeded if the input and output clamp current ratings are observed.

3. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

ESD SENSITIVITY CAUTION

This integrated circuit can be damaged if ESD protections are not considered carefully. SGMICRO recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because even small parametric changes could cause the device not to meet the published specifications.

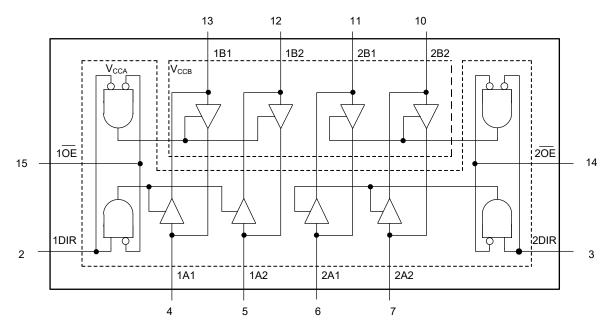
DISCLAIMER

SG Micro Corp reserves the right to make any change in circuit design, or specifications without prior notice.



4-Bit Dual-Supply Translating Transceiver with Configurable Voltage Translation and 3-State Outputs

LOGIC DIAGRAM



FUNCTION TABLE

SUPPLY VOLTAGE	CONTRO	L INPUT	INPUT/C	DUTPUT
$V_{CCA}, V_{CCB}^{(1)}$	nOE	nDIR	nAn	nBn
0.8V to 3.6V	L	L	nAn = nBn	Inputs
0.8V to 3.6V	L	Н	Inputs	nBn = nAn
0.8V to 3.6V	Н	X	Z	Z
GND ⁽²⁾	X	X	Z	Z

H = High Voltage Level

L = Low Voltage Level

Z = High-Impedance State

X = Don't Care

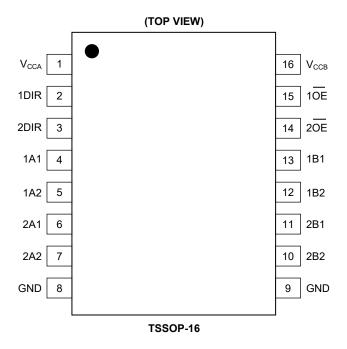
NOTES:

1. The nAn, nDIR and $n\overline{OE}$ signals are referenced to V_{CCA}. The nBn signals are referenced to V_{CCB}.

2. If at least one of V_{CCA} or V_{CCB} is at GND level, the device enters suspend mode.



PIN CONFIGURATION



PIN DESCRIPTION

PIN	NAME	FUNCTION
1	V _{CCA}	Supply Voltage $V_{CCA.}$ The nAn, nDIR and n \overline{OE} signals are referenced to $V_{CCA.}$
2, 3	1DIR, 2DIR	Direction Control Inputs.
4, 5	1A1, 1A2	Data Inputs/Outputs.
6, 7	2A1, 2A2	Data Inputs/Outputs.
8, 9	GND	Ground.
11, 10	2B1, 2B2	Data Inputs/Outputs.
13, 12	1B1, 1B2	Data Inputs/Outputs.
15, 14	10E, 20E	Output Enable Inputs (Active Low).
16	V _{ССВ}	Supply Voltage V_{CCB} . The nBn signals are referenced to V_{CCB} .



ELECTRICAL CHARACTERISTICS

(Full = -40°C to +125°C, all typical values are at T_A = +25°C. V_{CCI} is the supply voltage associated with the data input port, V_{CCO} is the supply voltage associated with the data output port, unless otherwise noted.)

PARAMETER	SYMBOL		CONDITIONS	TEMP	MIN	ТҮР	MAX	UNITS	
			V _{CCI} = 0.8V	Full	0.70 × V _{CCI}				
		Data Inputs	V _{CCI} = 1.1V to 1.95V	Full	0.65 × V _{CCI}				
			V _{CCI} = 2.3V to 2.7V	Full	1.6			- V	
High-Level Input	V _{IH}		V _{CCI} = 3.0V to 3.6V	Full	2				
Voltage	V _{IH}		V _{CCA} = 0.8V	Full	0.70 × V _{CCA}				
		nDIR, nOE	V _{CCA} = 1.1V to 1.95V	Full	$0.65 \times V_{CCA}$			v	
		inputs	V _{CCA} = 2.3V to 2.7V	Full	1.6			V	
			V _{CCA} = 3.0V to 3.6V	Full	2				
			V _{CCI} = 0.8V	Full			0.30 × V _{CCI}		
		Dete Innute	V _{CCI} = 1.1V to 1.95V	Full			0.35 × V _{CCI}	v	
		Data Inputs	V _{CCI} = 2.3V to 2.7V	Full			0.7		
Low-Level Input	VIL		V _{CCI} = 3.0V to 3.6V	Full			0.8		
Voltage	VIL		V _{CCA} = 0.8V	Full			0.30 ×V _{CCA}		
		nDIR, n OE inputs	V _{CCA} = 1.1V to 1.95V	Full			0.35 ×V _{CCA}	v	
			V _{CCA} = 2.3V to 2.7V	Full			0.7	v	
			V _{CCA} = 3.0V to 3.6V	Full			0.8		
			$I_{O} = -100 \mu A$, $V_{CCA} = V_{CCB} = 0.8V$ to 3.6V	Full	V _{CCO} - 0.1	V _{CCO} - 0.01			
			I_0 = -3mA, V_{CCA} = V_{CCB} = 1.1V	Full	0.85	0.98			
High-level Output	V _{OH}	VI = VIH	I_0 = -6mA, V_{CCA} = V_{CCB} = 1.4V	Full	1.05	1.22		v	
Voltage	- 011		I_0 = -8mA, V_{CCA} = V_{CCB} = 1.65V	Full	1.20	1.43			
			I_0 = -9mA, V_{CCA} = V_{CCB} = 2.3V	Full	1.75	2.09			
			I_0 = -12mA, V_{CCA} = V_{CCB} = 3.0V	Full	2.30	2.75			
			$I_{O} = 100 \mu A$, $V_{CCA} = V_{CCB} = 0.8V$ to 3.6V	Full		0.01	0.1		
			I_0 = 3mA, V_{CCA} = V_{CCB} = 1.1V	Full		0.10	0.25		
Low-Level Output	V _{OL}	$V_{I} = V_{IL}$	$I_0 = 6mA, V_{CCA} = V_{CCB} = 1.4V$	Full		0.16	0.35	v	
Voltage	• OL		$I_0 = 8mA, V_{CCA} = V_{CCB} = 1.65V$	Full		0.19	0.45] `	
			$I_0 = 9mA, V_{CCA} = V_{CCB} = 2.3V$	Full		0.18	0.55		
			$I_0 = 12mA$, $V_{CCA} = V_{CCB} = 3.0V$	Full		0.23	0.70		



ELECTRICAL CHARACTERISTICS (continued)

(Full = -40°C to +125°C, all typical values are at T_A = +25°C. V_{CCI} is the supply voltage associated with the data input port, V_{CCO} is the supply voltage associated with the data output port, unless otherwise noted.)

PARAMETER	SYMBOL		CONDITIONS	TEMP	MIN	TYP	MAX	UNITS	
Input Leakage Current	lı	· ·	nputs, V _I = 0V or 3.6V, : 0.8V to 3.6V	Full		±0.01	±5	μA	
		V _{CCA} = V _{CCB} =	= 3.6V, A or B ports, V ₀ = 0V or V _{CC0}	Full		±0.01	±5		
Off-State Output Current (1)	I _{oz}	$V_{CCA} = 3.6V, V_{O} = 0V \text{ or } V_{O}$	V _{CCB} = 0V, suspend mode A ports,	Full		±0.01	±5	μA	
		$V_0 = 0V \text{ or } V_0$	$_{CCO}$, $V_{CCA} = 0V$, $V_{CCB} = 3.6V$	Full		±0.01	±5		
Power-Off Leakage		$V_{CCA} = 0V, V_{CCB} = 0.8V$ to 3.6V, A ports, V _I or V _O = 0V to 3.6V Full			±0.01	±5			
Current	I _{OFF}	$V_{CCB} = 0V, V_{C}$	$_{\rm CCA}$ = 0.8V to 3.6V, B ports, V _I or V_O = 0V to 3.6V	V_{CCO} Full ± 0.01 ± 5 prts, Full ± 0.01 ± 5 Full ± 0.01 ± 5 r V_o = 0V to 3.6V Full ± 0.01 ± 5 r V_o = 0V to 3.6V Full ± 0.01 ± 5 average Full 1.4 10 1.4 10 1.2 10 1.4 10 1.2 10 1.4 10 0.01 5 average Full 0.01 5 average Full 0.7 10 1.4 15 1.4 15 average Full 0.01 5 average Full 0.01 5			μA		
			V_{CCA} = 0.8V to 3.6V, V_{CCB} = 0.8V to 3.6V	Full		1.4	10		
		A ports,	V _{CCA} = 1.1V to 3.6V, V _{CCB} = 1.1V to 3.6V	Full		1.2	10	μA	
		$V_{I} = 0V \text{ or}$ $V_{CCI}, I_{O} = 0A$	$V_{CCA} = 3.6V, V_{CCB} = 0V$	Full		0.01	5		
			V _{CCA} = 0V, V _{CCB} = 3.6V	Full		0.01	5		
			V_{CCA} = 0.8V to 3.6V, V_{CCB} = 0.8V to 3.6V	Full		0.8	10		
Supply Current	I _{CC}	B ports,	V _{CCA} = 1.1V to 3.6V, V _{CCB} = 1.1V to 3.6V	Full		0.7	10		
		$V_1 = 0V \text{ or}$ $V_{CCI}, I_0 = 0A$	$V_{CCA} = 3.6V, V_{CCB} = 0V$	Full		0.01	5	μA	
			V _{CCA} = 0V, V _{CCB} = 3.6V	Full		0.01	5		
			s ($I_{CCA} + I_{CCB}$), $I_0 = 0A$, $V_1 = 0V$ or V_{CC1} , o 3.6V, $V_{CCB} = 0.8V$ to 3.6V	Full		1.4	15	μA	
		A plus B ports (I_{CCA} + I_{CCB}), I_0 = 0A, V_1 = 0V or V_{CCI} , V_{CCA} = 1.1V to 3.6V, V_{CCB} = 1.1V to 3.6V		Full		1.2	15	μA	
Input Capacitance	Cı		nputs, $V_1 = 0V$ or 3.3V, $V_{CCA} = V_{CCB} = 3.3V$	+25°C		3.2		pF	
Input/Output Capacitance	C _{I/O}	A and B ports V _{CCA} = V _{CCB} =	s, suspend mode, V ₀ = V _{CC0} or GND, : 3.3V	+25°C		4.5		pF	

NOTE:

1. For I/O ports, the parameter I_{OZ} includes the input leakage current.



ELECTRICAL CHARACTERISTICS (continued)

Typical Total Supply Current (I_{CCA} + I_{CCB})

 $(T_A = +25^{\circ}C, unless otherwise noted.)$

N	V _{CCB}									
V _{CCA}	0V	0.8V	1.2V	1.5V	1.8V	2.5V	3.3V	UNITS		
0V	0	0.01	0.01	0.01	0.01	0.01	0.01	μA		
0.8V	0.01	0.01	0.01	0.01	0.03	0.20	0.60	μA		
1.2V	0.01	0.01	0.01	0.01	0.01	0.10	0.40	μA		
1.5V	0.01	0.01	0.01	0.01	0.01	0.03	0.30	μA		
1.8V	0.01	0.05	0.01	0.01	0.01	0.01	0.20	μA		
2.5V	0.01	0.40	0.20	0.06	0.02	0.01	0.02	μA		
3.3V	0.01	1.10	0.70	0.50	0.30	0.03	0.01	μA		

Typical Power Dissipation Capacitance

(T_A = +25°C, V_{CCA} = V_{CCB} , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	$V_{CCA} = V_{CCB}$						
	STWBOL	CONDITIONS	0.8V	1.2V	1.5V	1.8V	2.5V	3.3V	UNITS
		A ports: (direction nAn to nBn), output enabled	2.0	2.0	2.1	2.2	2.4	2.7	
		A ports: (direction nAn to nBn), output disabled	0.6	0.7	0.7	0.7	0.8	0.9	
		A ports: (direction nBn to nAn), output enabled	16.0	16.1	16.2	16.3	16.5	16.7	
Power Dissipation	CPD	A ports: (direction nBn to nAn), output disabled	1.4	1.3	1.4	1.4	1.6	1.7	рF
Capacitance ⁽¹⁾⁽²⁾	CPD	B ports: (direction nAn to nBn), output enabled	16.0	16.1	16.2	16.3	16.5	16.7	рг
		B ports: (direction nAn to nBn), output disabled	1.4	1.3	1.4	1.4	1.6	1.7	
		B ports: (direction nBn to nAn), output enabled	2.0	2.0	2.1	2.2	2.4	2.7	
		B ports: (direction nBn to nAn), output disabled	0.6	0.7	0.7	0.7	0.8	0.9	

NOTES:

1. C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_{D} = C_{PD} \times V_{CC}^{2} \times f_{i} \times N + \Sigma (C_{L} \times V_{CC}^{2} \times f_{o})$

where:

 f_i = Input frequency in MHz.

 f_o = Output frequency in MHz.

 C_L = Output load capacitance in pF.

 V_{CC} = Supply voltage in Volts.

N = Number of inputs switching.

 $\Sigma(C_L \times V_{CC}^2 \times f_o)$ = Sum of the outputs.

2. f_i = 10MHz, V_I = GND to V_{CC}, t_R = t_F = 1ns, C_L = 0pF, R_L = ∞ .



DYNAMIC CHARACTERISTICS

Typical Dynamic Characteristics at $V_{CCA} = 0.8V$ and $T_A = +25^{\circ}C$

(For test circuit, see Figure 1, for waveforms see Figure 2 and Figure 3, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	V _{CCB}						
	STMBOL	CONDITIONS	0.8V	1.2V	1.5V	1.8V	2.5V	3.3V	UNITS
Propagation Delay ⁽¹⁾	+	nAn to nBn	31.9	11.1	9.8	9.5	9.7	10.2	20
Propagation Delay	t _{PD}	nBn to nAn	33.8	21.0	18.0	17.7	17.2	17.1	ns
Disable Time	t _{DIS}	nOE to nAn	30.6	30.5	30.6	32.6	32.5	39.0	20
Disable Time		nOE to nBn	31.2	20.2	19.3	19.4	18.8	19.8	ns
Enable Time		nOE to nAn	44.4	44.2	44.2	44.2	44.4	44.3	
	t _{EN}	nOE to nBn	38.4	18.2	16.9	16.6	16.8	17.8	ns

NOTE:

1. t_{PD} is the same as t_{PLH} and t_{PHL} , t_{DIS} is the same as t_{PLZ} and t_{PHZ} , t_{EN} is the same as t_{PZL} and t_{PZH} .

Typical Dynamic Characteristics at $V_{CCB} = 0.8V$ and $T_A = +25^{\circ}C$

(For test circuit, see Figure 1, for waveforms see Figure 2 and Figure 3, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	V _{CCA}						UNITS
	STMBOL	CONDITIONS	0.8V	1.2V	1.5V	1.8V	2.5V	3.3V	UNITS
Propagation Dolou ⁽¹⁾		nAn to nBn	30.2	26.6	25.9	24.6	24.1	24.0	20
Propagation Delay ⁽¹⁾	t _{PD}	nBn to nAn	32.0	11.1	9.8	9.4	9.4	9.9	ns
Dia ahla Tima		nOE to nAn	30.5	9.0	6.3	5.8	4.3	5.5	
Disable Time	t _{DIS}	nOE to nBn	31.1	21.5	20.1	21.1	20.6	26.7	ns
Enable Time		nOE to nAn	44.3	10.4	6.5	5.0	3.8	3.3	
	t _{EN}	nOE to nBn	38.9	30.5	29.0	28.1	27.8	27.5	ns

NOTE:

1. t_{PD} is the same as t_{PLH} and t_{PHL} , t_{DIS} is the same as t_{PLZ} and t_{PHZ} , t_{EN} is the same as t_{PZL} and t_{PZH} .



DYNAMIC CHARACTERISTICS (continued)

Dynamic Characteristics

(For test circuit, see Figure 1, for waveforms see Figure 2 and Figure 3. Full = -40° C to $+125^{\circ}$ C, all typical values are at T_A = $+25^{\circ}$ C, unless otherwise noted.)

			V _{CCB}									
PARAMETER	SYMBOL	CONDITIONS	1.2V ± 0.1V		1.5V ± 0.1V			1.8V ± 0.15V			UNITS	
			MIN ⁽¹⁾	TYP	MAX ⁽¹⁾	MIN ⁽¹⁾	TYP	MAX ⁽¹⁾	MIN ⁽¹⁾	TYP	MAX ⁽¹⁾	
V _{CCA} = 1.1V to 1.3V		•										
Dramatian Dalar (2)		nAn to nBn	0.5	8.9	15.0	0.5	6.5	10.5	0.5	5.9	9.4	
Propagation Delay ⁽²⁾	t _{PD}	nBn to nAn	0.5	8.9	14.9	0.3	7.6	12.3	0.1	7.1	11.7	ns
Disable Time	+	nOE to nAn	1.8	10.5	15.0	1.8	10.2	15.4	1.8	10.5	15.8	5
	t _{DIS}	$n\overline{OE}$ to nBn	1.9	10.0	15.2	1.9	8.4	12.3	1.9	8.0	11.7	ns
Enable Time	+	$n\overline{OE}$ to nAn	1.4	12.6	20.3	1.4	12.9	20.3	1.4	13.2	20.4	20
	t _{EN}	$n\overline{OE}$ to nBn	1.1	11.1	17.5	1.1	8.9	13.2	1.1	8.3	12.0	ns
V _{CCA} = 1.4V to 1.6V												
Propagation Delay (2)	t _{PD}	nAn to nBn	0.3	7.4	12.1	0.3	5.4	8.4	0.3	4.7	7.4	ne
Propagation Delay	чРD	nBn to nAn	0.5	6.4	10.4	0.3	5.3	8.4	0.1	4.8	7.6	ns
Disable Time	t	nOE to nAn	1.8	6.9	11.8	1.8	6.3	11.8	1.5	7.4	11.8	ns
	t _{DIS}	nOE to nBn	1.9	7.7	13.0	1.9	6.0	11.9	1.9	5.6	10.6	10
Enable Time	t _{en}	nOE to nAn	1.1	7.1	10.9	1.1	7.3	11.0	0.7	7.5	11.0	ns
	^L EN	$n\overline{OE}$ to nBn	1.4	8.9	11.1	1.1	6.6	9.0	0.9	5.7	9.0	
V _{CCA} = 1.65V to 1.95V		-		-		-						
Propagation Delay ⁽²⁾	t _{PD}	nAn to nBn	0.1	7.0	11.7	0.1	4.8	7.7	0.1	4.1	6.6	ns
	ΨD	nBn to nAn	0.5	5.8	9.3	0.3	4.7	7.0	0.1	4.1	6.5	
Disable Time	t _{DIS}	$n\overline{OE}$ to nAn	1.8	6.0	11.8	1.6	5.2	10.0	1.8	5.5	10.0	ns
	UIS	nOE to nBn	1.7	7.2	12.5	1.7	5.3	11.4	1.6	5.1	10.1	113
Enable Time	t _{EN}	nOE to nAn	1.0	5.4	8.5	1.0	5.5	8.5	1.0	5.4	8.5	ns
	4EN	$n\overline{OE}$ to nBn	1.2	8.1	13.4	1.2	5.6	10.7	1.0	5.1	8.7	113
V _{CCA} = 2.3V to 2.7V		-		-		-						
Propagation Delay ⁽²⁾	t _{PD}	nAn to nBn	0.1	6.6	11.1	0.1	4.4	7.1	0.1	3.7	5.9	ns
r ropugution Doluy	ΨD	nBn to nAn	0.5	5.2	8.4	0.3	4.1	6.2	0.1	3.5	5.5	110
Disable Time	t _{DIS}	nOE to nAn	4.3	5.0	7.4	1.0	4.1	7.4	1.0	4.9	7.4	ns
	1015	nOE to nBn	6.7	6.7	12.0	1.5	4.8	10.9	1.3	4.5	9.6	110
Enable Time	t _{EN}	nOE to nAn	0.7	3.7	5.8	0.7	3.8	5.8	0.7	3.8	5.8	ns
	4EIN	nOE to nBn	0.9	7.3	12.9	0.9	4.9	10.2	0.8	4.3	8.2	110
V _{CCA} = 3.0V to 3.6V				r		r		-		1		
Propagation Delay ⁽²⁾	t _{PD}	nAn to nBn	0.1	6.4	10.8	0.1	4.3	6.8	0.1	3.6	5.7	ns
· · · · · · · · · · · · · · · · · · ·	·ru	nBn to nAn	0.5	5.2	8.3	0.3	3.9	5.8	0.3	3.3	5.0	
Disable Time	t _{DIS}	$n\overline{OE}$ to nAn	0.7	3.8	6.7	0.7	3.7	6.7	0.7	3.9	6.7	ns
2.00.010 11110	5 IU	nOE to nBn	1.4	6.6	11.8	1.4	4.7	10.8	1.2	4.3	9.5	110
Enable Time	t _{EN}	$n\overline{OE}$ to nAn	0.6	3.2	4.7	0.6	3.1	4.7	0.6	3.2	4.7	ns
	•CIN	$n\overline{OE}$ to nBn	0.8	7.2	12.9	0.8	4.6	10.1	0.6	4.0	8.0	

NOTES:

1. Specified by design and characterization, not production tested.

2. t_{PD} is the same as t_{PLH} and t_{PHL} , t_{DIS} is the same as t_{PLZ} and t_{PHZ} , t_{EN} is the same as t_{PZL} and t_{PZH} .



DYNAMIC CHARACTERISTICS (continued)

Dynamic Characteristics

(For test circuit, see Figure 1, for waveforms see Figure 2 and Figure 3. Full = -40° C to $+125^{\circ}$ C, all typical values are at T_A = $+25^{\circ}$ C, unless otherwise noted.)

			V _{CCB}						
PARAMETER	SYMBOL	CONDITIONS		2.5V ± 0.2	/		3.3V ± 0.3	/	UNITS
			MIN ⁽¹⁾	TYP	MAX ⁽¹⁾	MIN ⁽¹⁾	TYP	MAX ⁽¹⁾	
V _{CCA} = 1.1V to 1.3V									
December Delew (2)		nAn to nBn	0.5	5.3	8.5	0.5	5.1	8.4	
Propagation Delay ⁽²⁾	t _{PD}	nBn to nAn	0.1	6.6	11.1	0.1	6.4	10.7	ns
Dischle Time	+	nOE to nAn	1.8	10.2	15.5	1.8	11.2	16.0	
Disable Time	t _{DIS}	nOE to nBn	1.4	7.4	10.8	1.2	8.7	12.4	ns
Frankla Tima		nOE to nAn	1.4	14.5	22.5	1.4	15.9	23.4	
Enable Time	t _{EN}	nOE to nBn	1.0	7.7	11.2	1.0	7.6	11.1	ns
V _{CCA} = 1.4V to 1.6V	•						•	•	
Propagation Delay ⁽²⁾		nAn to nBn	0.3	4.1	6.2	0.3	3.9	5.8	20
	t _{PD}	nBn to nAn	0.1	4.3	6.9	0.1	4.2	6.7	- ns
		nOE to nAn	1.3	6.3	11.8	1.6	8.3	11.8	
Disable Time	t _{DIS}	nOE to nBn	1.4	5.0	8.7	1.2	5.3 8.1 5.2	8.9	ns
Frankla Tima		nOE to nAn	0.7	7.7	11.1	0.4	8.1	11.9	
Enable Time	t _{en}	nOE to nBn	0.9	5.4	7.9	0.9	5.2	7.7	ns
V _{CCA} = 1.65V to 1.95V									
Propagation Delay ⁽²⁾		nAn to nBn	0.1	3.5	5.4	0.3	3.3	5.1	
	t _{PD}	nBn to nAn	0.1	3.7	5.9	0.1	3.6	5.7	ns
Diachla Tima	+	nOE to nAn	1.3	5.1	10.0	1.6	6.5	10.0	ns ns
Disable Time	t _{DIS}	nOE to nBn	1.2	4.4	8.1	1.0	4.7	8.1	
Enchle Time		nOE to nAn	0.6	5.5	8.5	0.4	5.9	8.6	
Enable Time	t _{EN}	nOE to nBn	0.8	5.8	7.7	0.8	5.5	7.3	ns
V _{CCA} = 2.3V to 2.7V									
Dropogation Daloy ⁽²⁾	•	nAn to nBn	0.2	3.1	4.7	0.1	2.8	4.5	20
Propagation Delay ⁽²⁾	t _{PD}	nBn to nAn	0.2	3.1	4.8	0.1	3.0	4.6	ns
Dia ahla Tirra		nOE to nAn	1.0	3.9	7.4	1.0	5.0	7.4	
Disable Time	t _{DIS}	nOE to nBn	1.1	3.8	7.4	0.9	4.2	6.3	ns
Enable Time	+	nOE to nAn	0.6	3.9	5.8	0.4	3.9	5.8	
Enable Time	t _{EN}	nOE to nBn	0.6	3.6	5.8	0.6	3.4	4.9	ns
V _{CCA} = 3.0V to 3.6V									
Propagation Delay ⁽²⁾	+	nAn to nBn	0.1	3.0	4.5	0.1	2.7	4.1	
Fropagation Delay	t _{PD}	nBn to nAn	0.1	2.9	4.5	0.1	2.8	4.2	ns
	+	nOE to nAn	0.7	3.7	6.7	0.7	4.4	6.7	
Disable Time	t _{DIS}	nOE to nBn	1.0	3.8	7.6	0.8	4.0	7.4	ns
Enchla Tim-		nOE to nAn	0.6	3.2	4.7	0.4	3.3	4.7	
Enable Time	t _{EN}	nOE to nBn	0.5	3.3	5.7	0.5	3.1	4.7	ns

NOTES:

1. Specified by design and characterization, not production tested.

2. t_{PD} is the same as t_{PLH} and t_{PHL} , t_{DIS} is the same as t_{PLZ} and t_{PHZ} , t_{EN} is the same as t_{PZL} and t_{PZH} .

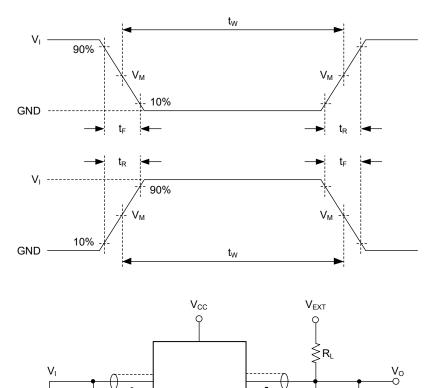


4-Bit Dual-Supply Translating Transceiver with Configurable Voltage Translation and 3-State Outputs

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 C_{L}

TEST CIRCUIT



74AVC4T245Q

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Test conditions are given in Table 1.

Definitions for test circuit:

RL: Load resistance.

C_L: Load capacitance (includes jig and probe).

 R_T : Termination resistance (equals to output impedance Z_0 of the pulse generator).

 V_{EXT} : External voltage used to measure switching time.

Figure 1. Test Circuit for Measuring Switching Times

Table 1. Test Conditions									
SUPPLY VOLTAGE	INPUT		LO	AD	V _{EXT}				
V _{CCA} , V _{CCB}	VI ⁽¹⁾	Δt/ΔV	CL	RL	t _{PLH} , t _{PHL}	t _{PZH} , t _{PHZ}	t_{PZL}, t_{PLZ}		
0.8V to 1.6V	V _{CCI}	≤ 1.0ns/V	15pF	2kΩ	Open	GND	2 × V _{CCO}		
1.65V to 2.7V	V _{CCI}	≤ 1.0ns/V	15pF	2kΩ	Open	GND	2 × V _{CCO}		
3.0V to 3.6V	V _{CCI}	≤ 1.0ns/V	15pF	2kΩ	Open	GND	2 × V _{CCO}		

NOTES:

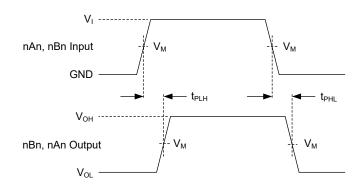
1. V_{CCI} is the supply voltage associated with the data input port.

2. V_{CCO} is the supply voltage associated with the data output port.



4-Bit Dual-Supply Translating Transceiver with **Configurable Voltage Translation and 3-State Outputs**

WAVEFORMS

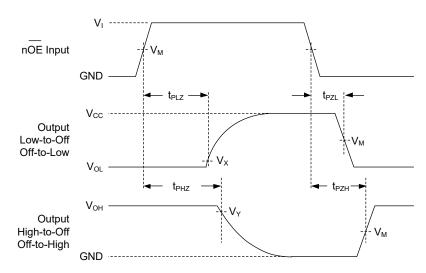


Test conditions are given in Table 1.

Measurement points are given in Table 2.

Logic levels: V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Figure 2. Input (nAn, nBn) to Output (nBn, nAn) Propagation Delay Times



Test conditions are given in Table 1. Measurement points are given in Table 2. Logic levels: V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Figure 3. Enable and Disable Times

SUPPLY VOLTAGE	INPUT ⁽¹⁾		OUTPUT				
V_{CCA}, V_{CCB}	Vı	V _M ⁽²⁾	V _M ⁽³⁾	V _x	V _Y		
0.8V to 1.6V	V _{CCI}	$0.5 \times V_{CCI}$	$0.5 \times V_{CCO}$	V _{OL} + 0.1V	V _{OH} - 0.1V		
1.65V to 2.7V	V _{CCI}	$0.5 \times V_{CCI}$	$0.5 \times V_{CCO}$	V _{OL} + 0.15V	V _{OH} - 0.15V		
3.0V to 3.6V	V _{CCI}	$0.5 \times V_{CCI}$	$0.5 \times V_{CCO}$	V _{OL} + 0.3V	V _{OH} - 0.3V		

Table 2 Measurement Points

NOTES:

1. V_{CCI} is the supply voltage associated with the data input port.

- 2. The measurement points should be V_{IH} or V_{IL} when $\Delta t/\Delta V > 1.0$ ns/V.
- 3. V_{CCO} is the supply voltage associated with the data output port.



REVISION HISTORY

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (SEPTEMBER 2022) to REV.A

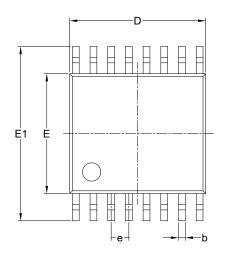
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Changed from product preview to production dataA	1

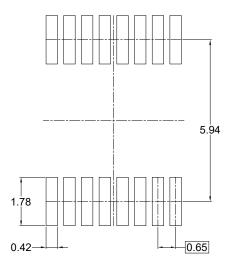


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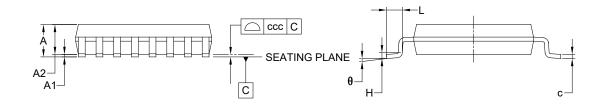
PACKAGE OUTLINE DIMENSIONS

TSSOP-16





RECOMMENDED LAND PATTERN (Unit: mm)



Or weak a l	D	Dimensions In Millimeters							
Symbol	MIN	MOD	МАХ						
А	-	-	1.200						
A1	0.050	-	0.150						
A2	0.800	-	1.050						
b	0.190	-	0.300						
С	0.090	-	0.200						
D	4.860	-	5.100						
E	4.300	-	4.500						
E1	6.200	-	6.600						
e		0.650 BSC							
L	0.450	-	0.750						
н		0.250 TYP							
θ	0°	-	8°						
CCC		0.100							

NOTES:

1. This drawing is subject to change without notice.

2. The dimensions do not include mold flashes, protrusions or gate burrs.

3. Reference JEDEC MO-153.



TAPE AND REEL INFORMATION

REEL DIMENSIONS

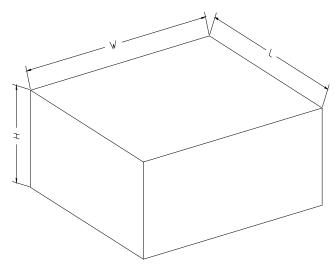


NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF TAPE AND REEL

Package Type	Reel Diameter	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
TSSOP-16	13″	12.4	6.80	5.40	1.50	4.0	8.0	2.0	12.0	Q1

CARTON BOX DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF CARTON BOX

Reel Type	Length (mm)	Width (mm)	Height (mm)	Pizza/Carton	
13″	386	280	370	5	DD0002

